Electronics/DAQ status

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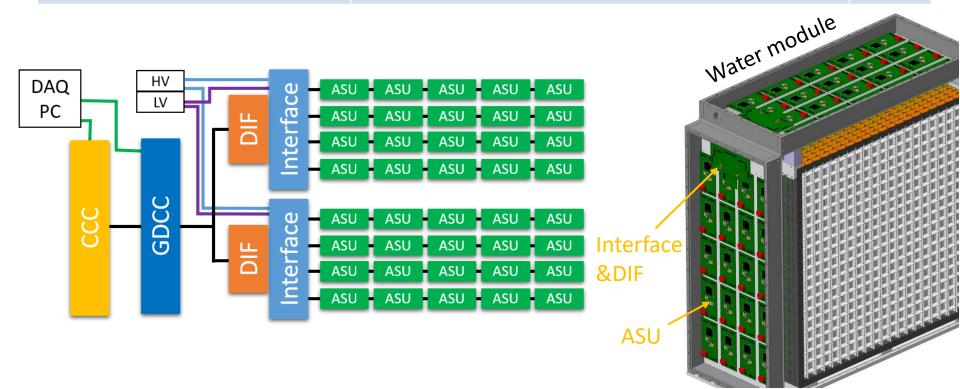
東京大学

Tuesday, May 23, 2017

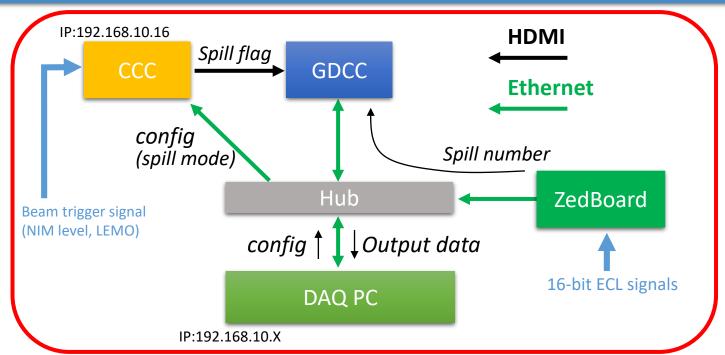
- □ Spill information implementation & Online monitor development
 - ➤ Basic system has been completed.
- □ Issue on the Interface board?
 - > Failed to configure 20 ASUs on an Interface board.
 - ➤ Nets for slow control signals are suspected.
- □What's remaining on electronics/DAQ development.
 - ➤ Solve electronics issues (probably on Interface board).
 - ✓ Then, measure all ASU boards for test operation and calibration.
 - ➤ Slow monitor
 - ✓ Power supplies (HV, LV), Water level sensor, Humidity sensor...
 - ➤ Prepare for data storage and offline analysis.
 - ✓ Including purchase of PCs.

WAGASCI electronics

| Electronics boards | | Num /Mod |
|---|--|-------------|
| ASU (Active Sensor Unit) | Readouts a 32ch MPPC array with a SPIROC chip. | 40 |
| Interface | Transfers DAQ signals and MPPC bias voltage. | 2 |
| DIF (Detector InterFace) | Send DAQ signals and SPIROC configuration. | 2 |
| GDCC (Giga Data Concentrator Card) | Transfer signals between DAQ PC and DIFs. | 1 |
| CCC (Clock & Control Card) | Provides clock signals and fast control. | 1 |



Spill Information Implementation





- $\emph{Spill flag}$: via HDMI
 - Generated in the *CCC* firmware to its state.
 - 0x82 -> NU beam acquisition.
 - 0x92 -> Internal acquisition.
- **Spill number**: via Ethernet

External 16-bit signal from beamline.

ZedBoard receives it and send it on Ethernet.

- → Filled into GDCC headers.
- → Decoded with other DIF/SPIROC data.

Ethernet frame

- CCC : SiTCP using a fixed IP address.
- GDCC, ZedBoard: Raw Ethernet frame only using MAC addresses.

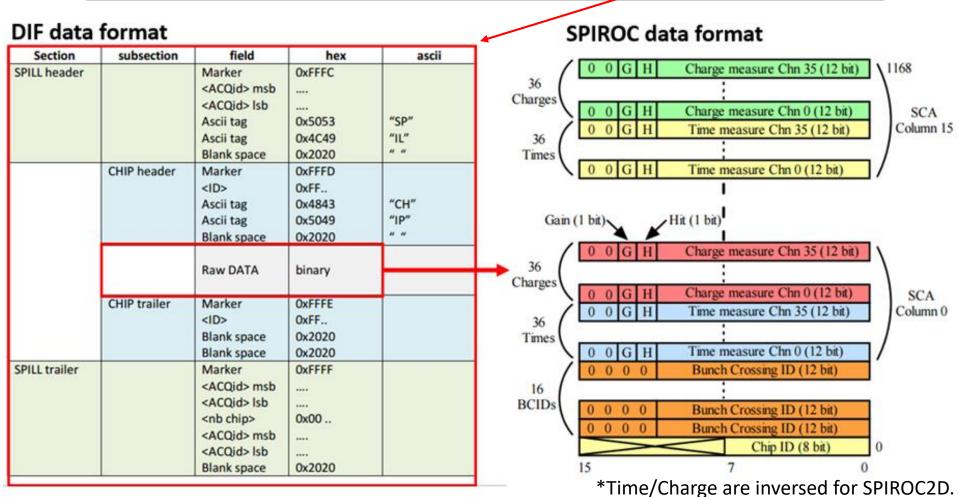
0x0809 -> Fast Command Packet

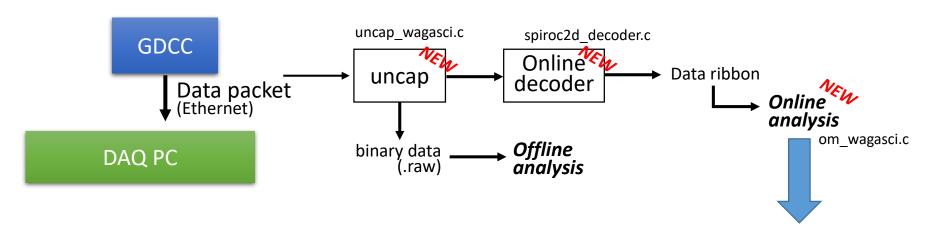
0x0810 -> Normal GDCC Packet

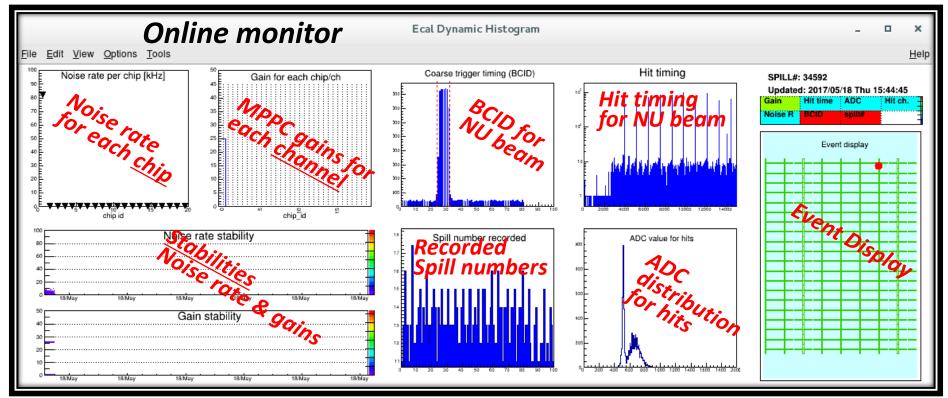
0x0811 -> DIF Data Packet

GDCC packet format

| Dst | Src | Ethernet | GDCC_Ty | GDCC_Modifier | GDCC_PktID | GDCC_DataLength | GDCC_Data | PAD | CRC32 |
|------------|------------|----------|---------|---------------|------------|--|-----------|------------------------------------|-------|
| <i>MAC</i> | MAC | Type | pe | | | | | | |
| 6 Bytes | 6 Bytes | 2 Bytes | 2 Bytes | 2 Bytes | | 2 Bytes used for spill flag | | Pad to Min Ethern et Size | |



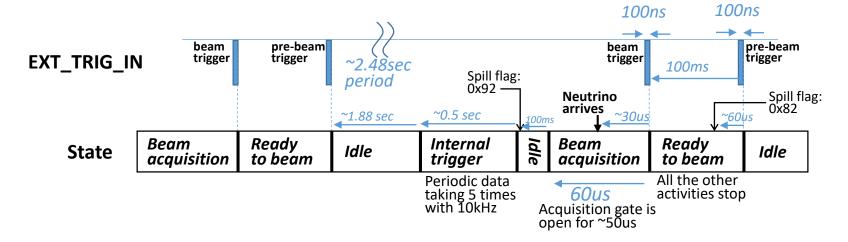


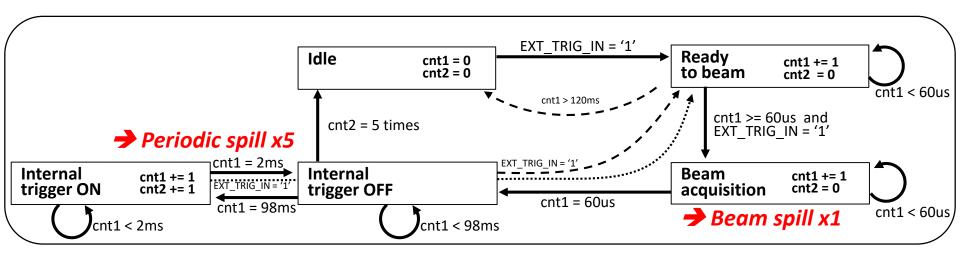


^{*}These test plots are made just with test data.

Acquisition Control to the Beam Trigger

☐ To generate "spill" signal from the external "beam trigger".





^{*}Spill flags are changed right before the acquisition.

^{*}This state machine works even with 1.3sec period.

Status of electronics boards

- ■All boards have been fabricated.
 - >50 ASUs ... Each single board has been checked to correctly work at UTokyo.
 - *<u>Up to 4 ASUs</u> are set in parallel/serial, and it works.
 - ➤ 4 Interfaces ... 2 boards are correctly operated with a single ASU,
 - the others are NOT.

 → Investigated, but no cause found.
 - ➤ DIF ... 33 boards are checked at LLR.
 - ➤GDCC/CCC ... 9 boards (6 GDCC/3 CCC) are OK.

☐ Failed to operate with many ASUs.

➤ It fails to configure when ~10ASUs are set on an Interface board.







Issue on Readout on Many ASUs

□ *Under investigation*

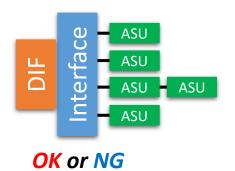
- ➤ It seems that it fails to configure all ASUs.
- The behavior depends on numbers of ASUs.

*Test with the first production.





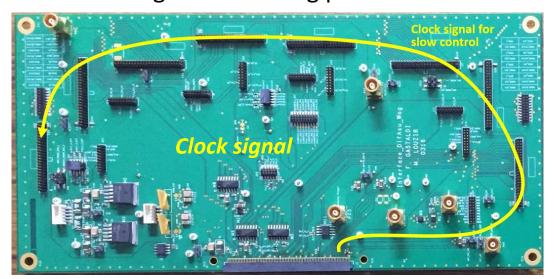
*Other various configurations have been checked.

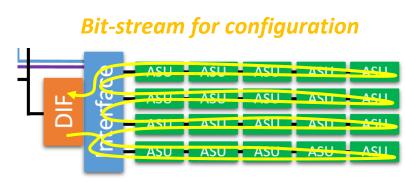


- The behavior seems more unstable when the 2nd to 4th ASU line has more boards.
- ➤ Even adding a capacitor or putting a probe pin may sometimes improve the behavior.

□ Under investigation

- The most probable cause is that slow control signals are broken by large capacity of ASUs?
 - ✓ These signals have long paths on the Interface board and ASUs.





➤ Possible solution?

- ✓ <u>Changing a buffer IC</u> on the Interface board, providing the slow control clock signals for each ASU line?
- ✓ <u>Lowering the frequency of slow control clock</u> in the DIF firmware?
- → We need to keep investigation, and if needed, some update will be done on the Interface board.

□ToDo list

- Control/monitor system of power supplies (HV, LV), and water level sensor.
 - ✓ Remote control of ZUP PS units.
 - ✓ Data logger for water level sensor.
- ➤ Prepare for offline analysis.
 - ✓ Data storage.
 - ◆KEKCC, Kyoto, or any other?
 - ✓ Other PCs than the front-end node?
 - ✓ Auto-processes codes.

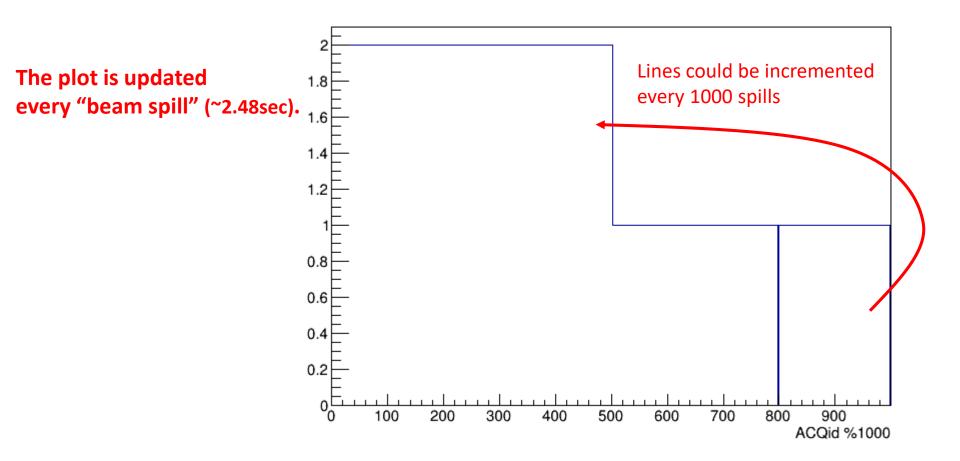
□Summary

- ➤ Spill information implementation has been basically completed.
- The basic plots for online monitors has been built.
- Electronics boards have been ready, but we found a new issue probably on the Interface board.
- This issue is the most urgent point to be solved.

Supplemental slides

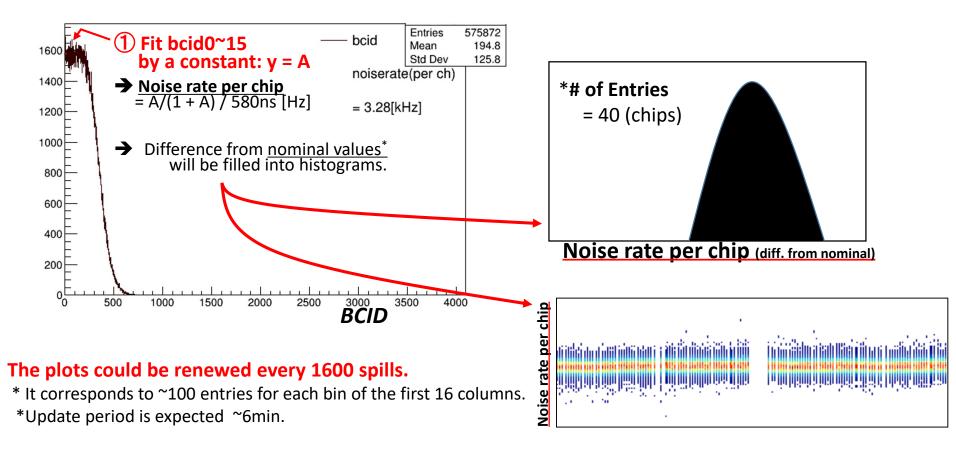
1. Acquisition ID plots with good data format

- To monitor if the data taking efficiency is as expected.
- * After "spill flag" and "spill number" will be implemented, this plots should be produced only for the "beam spills" with the spill number instead of acquisition ID.



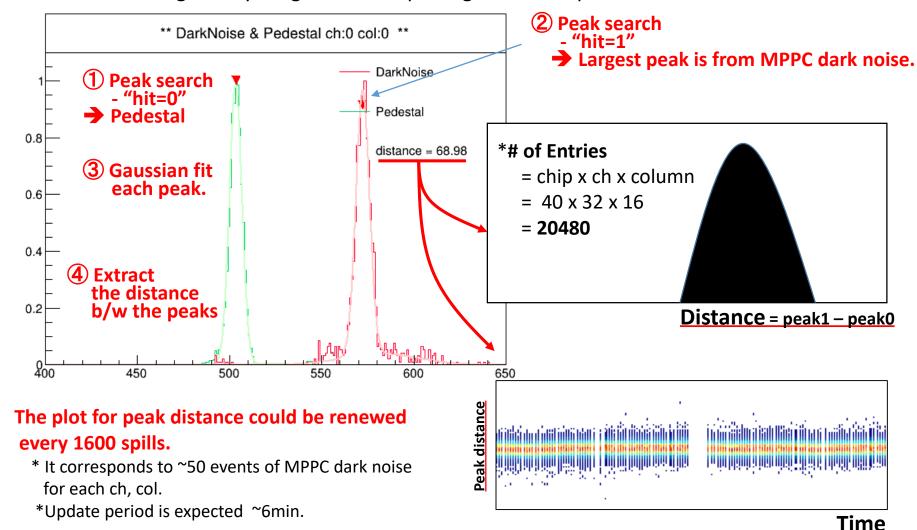
2. Noise rate per chip by BCID

- To monitor if any unexpected noise affects the data taking and if the noise rate corresponds to the MPPC noise rate.
- * After "spill flag" and "spill number" will be implemented, this plots should be produced only for the "periodic spills".



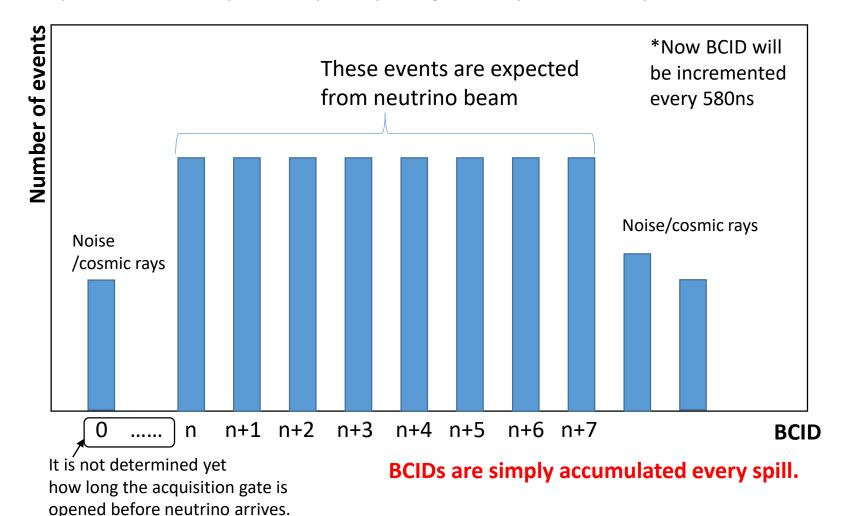
^{*}Nominal value will be measured for each chip. Temporarily, 3kHz can be used for all chip.

- 3. Distance charge ADC b/w pedestal peak and MPPC dark-noise peak.
 - To monitor the stability of MPPC gain.
 - *It requires to extract only the "periodic spills" and to remove beam spills, by using "spill flag". It is ok to merge everything until the "spill flag" will be implemented.



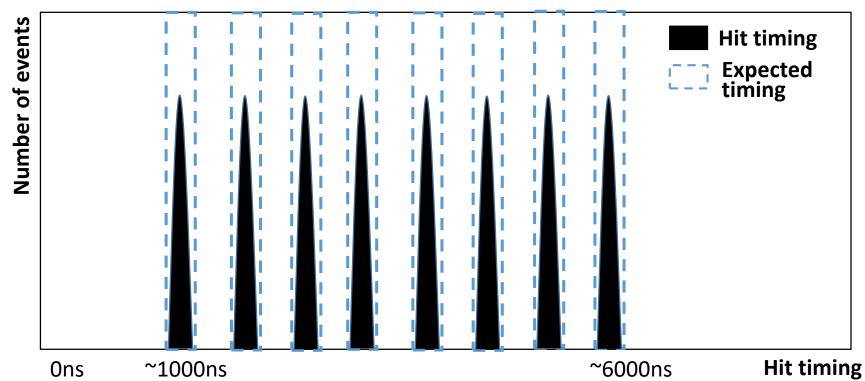
4. Trigger timing plots (coarse) by BCID

- To monitor if the neutrino events are triggered on expected timing.
- * After "spill flag" will be implemented, this plots should be separated by the spill flag and only the "beam spills" should be extracted.



5. Hit timing plots (fine) by time measurement

- To monitor the hit timing.
- * After "spill flag" will be implemented, this plots should be separated by the spill flag and only the "beam spills" should be extracted.



Hit timings are simply accumulated every spill.

The const A,B,C,D will be measured for each chip/ch/col.

*Temporarily,

$$A = 500$$

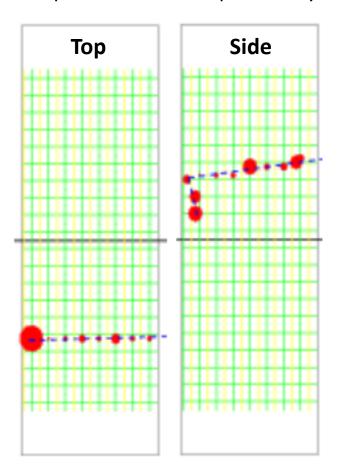
$$B = D = 1$$
ns

$$C = 4096$$

can be used for all chip/ch/col

6. Event display

* After "spill flag" will be implemented, this plots should be separated by the spill flag and only the "beam spills" should be extracted.



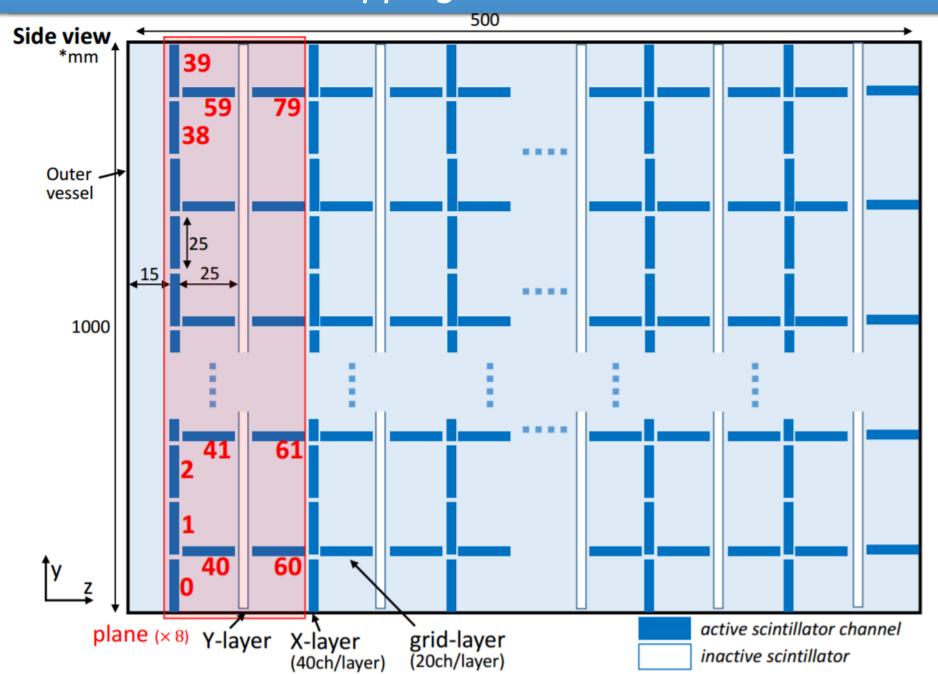
- Event display can be updated as follows.
 - Only when it has 3 hits for each view on the same boid (or ± 1), the display can be updated.
 - Once it is updated, it needs to wait for <u>10sec</u>* at least.

*This 10sec needs to be optimized later.

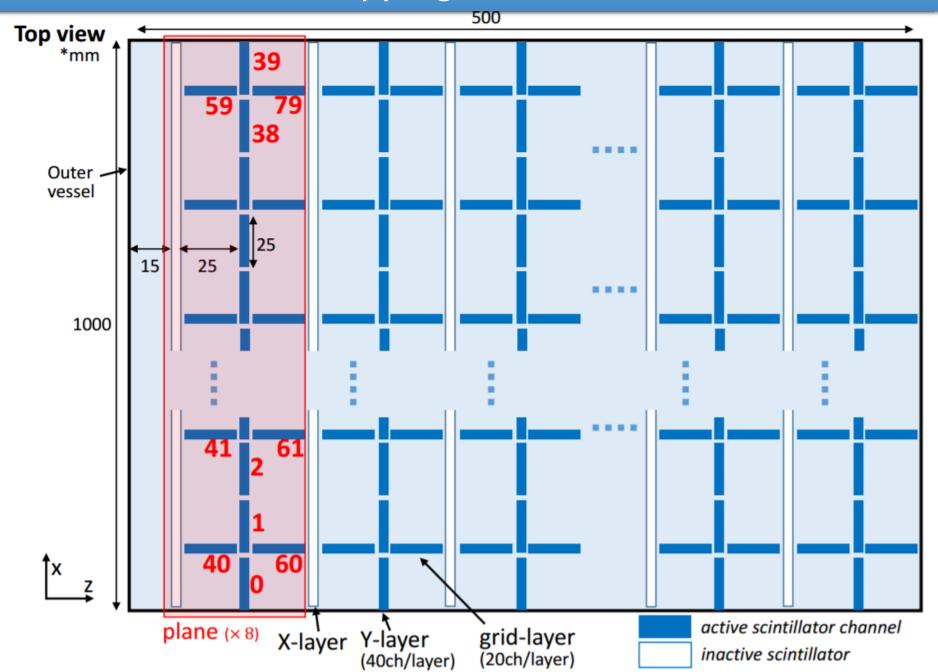
- **♦** Size of dots can show the corresponding charge value.
- The correspondence between DIF/ASU and module VIEW/PLN/CH is written in the table*
- ◆ The distribution of module VIEW/PLN/CH is written in the next page.

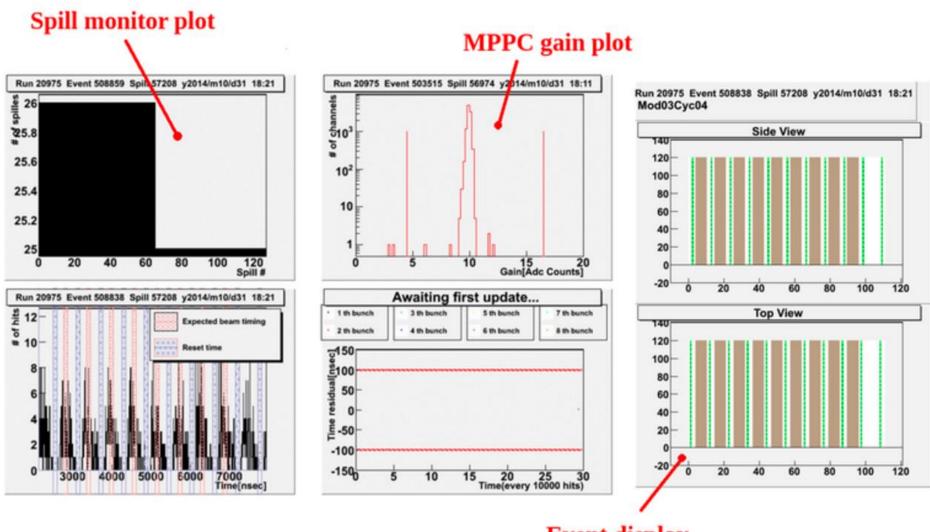
^{*&}lt;u>Table</u>: The correspondence between SPIROC chip#/ch# and WAGASCI module view/pln/channel. http://www-he.scphys.kyoto-u.ac.jp/member/hayashino/B2Water/dokuwiki/lib/exe/fetch.php?media=chikuma:channel_mapping.xlsx Side view = 0 , Top view=1.

WAGASCI channel mapping



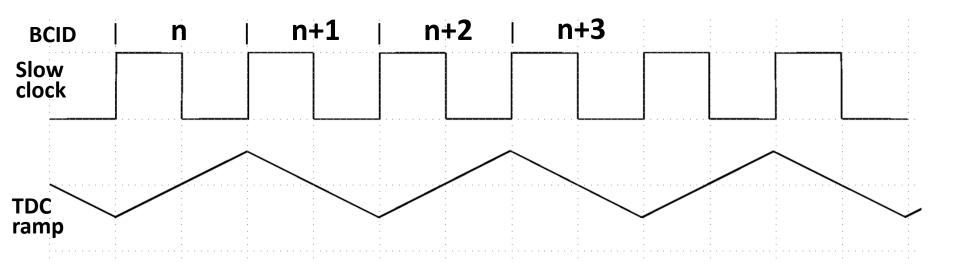
WAGASCI channel mapping



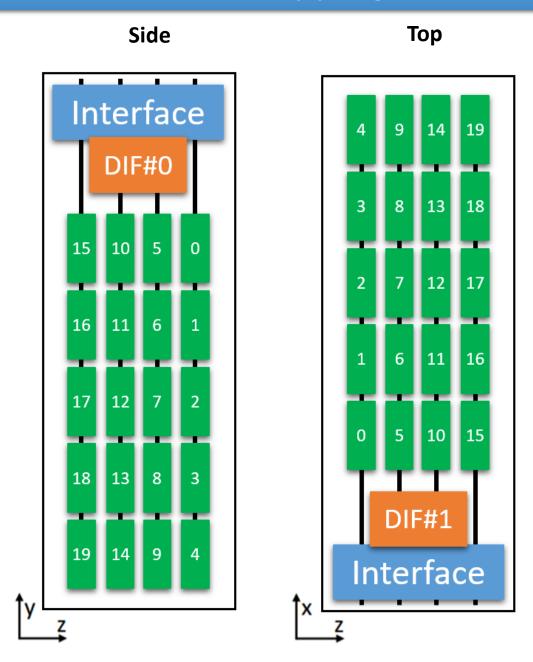


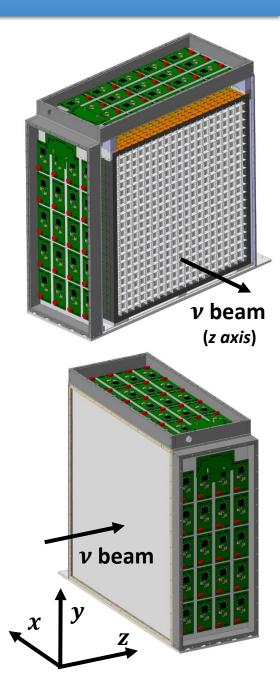
Event display

- ■BCID is incremented every slow clock edge.
- ☐Timing is measured by TDC signal with rising and falling ramps.
 - It needs to be inversed by which of even/odd the bcid is.

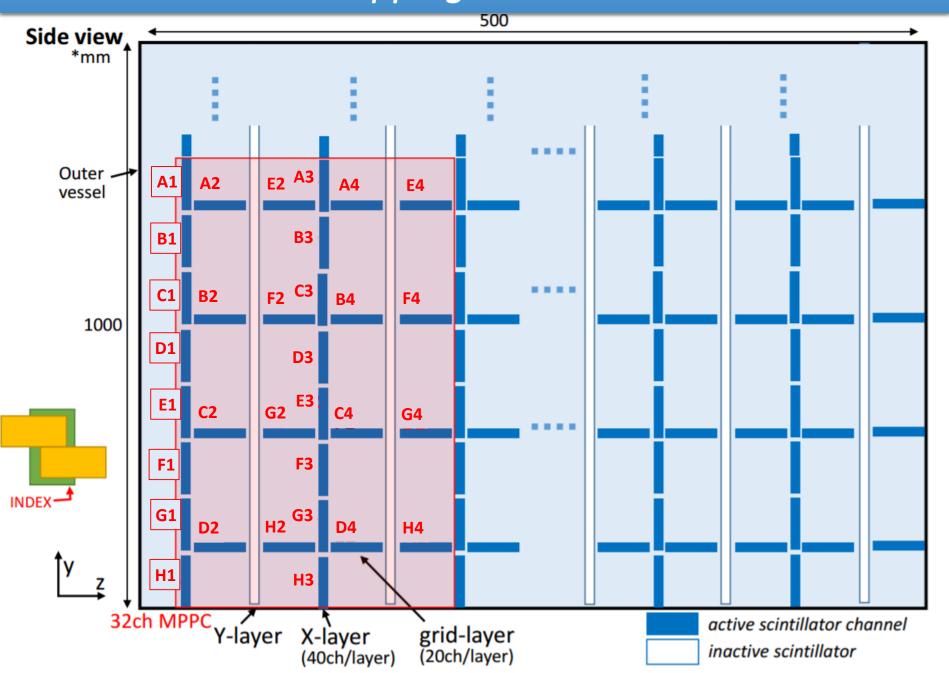


WAGASCI ASU mapping

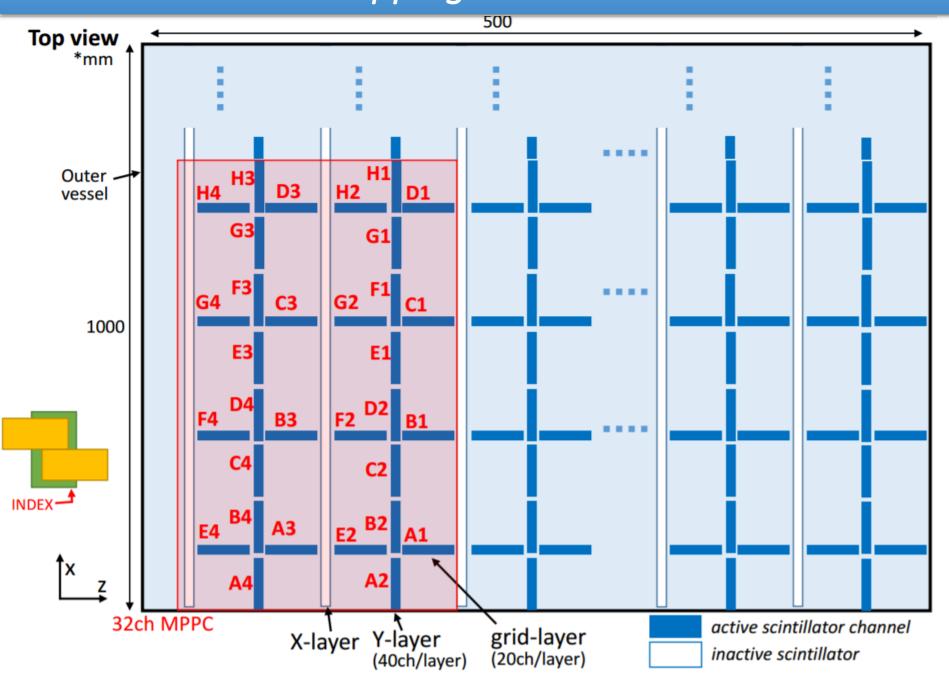




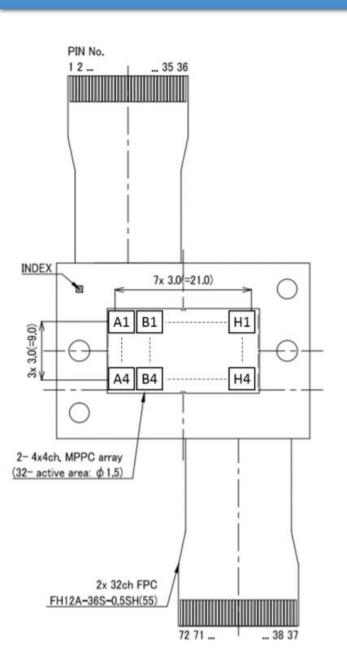
WAGASCI channel mapping



WAGASCI channel mapping



MPPC channel mapping



| FPC No. | ch. No. |
|---------|---------|---------|---------|---------|---------|---------|---------|
| 1 | A(A4) | 19 | A(C4) | 37 | A(H1) | 55 | A(F1) |
| 2 | A(A3) | 20 | A(C3) | 38 | A(H2) | 56 | A(F2) |
| 3 | A(A2) | 21 | A(C2) | 39 | A(H3) | 57 | A(F3) |
| 4 | A(A1) | 22 | A(C1) | 40 | A(H4) | 58 | A(F4) |
| 5 | A(B4) | 23 | A(D4) | 41 | A(G1) | 59 | A(E1) |
| 6 | A(B3) | 24 | A(D3) | 42 | A(G2) | 60 | A(E2) |
| 7 | A(B2) | 25 | A(D2) | 43 | A(G3) | 61 | A(E3) |
| 8 | A(B1) | 26 | A(D1) | 44 | A(G4) | 62 | A(E4) |
| 9 | NC | 27 | NC | 45 | NC | 63 | NC |
| 10 | K(A4) | 28 | K(C4) | 46 | K(H1) | 64 | K(F1) |
| 11 | K(A3) | 29 | K(C3) | 47 | K(H2) | 65 | K(F2) |
| 12 | K(A2) | 30 | K(C2) | 48 | K(H3) | 66 | K(F3) |
| 13 | K(A1) | 31 | K(C1) | 49 | K(H4) | 67 | K(F4) |
| 14 | K(B4) | 32 | K(D4) | 50 | K(G1) | 68 | K(E1) |
| 15 | K(B3) | 33 | K(D3) | 51 | K(G2) | 69 | K(E2) |
| 16 | K(B2) | 34 | K(D2) | 52 | K(G3) | 70 | K(E3) |
| 17 | K(B1) | 35 | K(D1) | 53 | K(G4) | 71 | K(E4) |
| 18 | NC | 36 | NC | 54 | NC | 72 | NC |

A: Anode

K: Cathode

NC: No connection